## IN THE U.S. PATENT AND TRADEMARK OFFICE

In re application of

Jean-Pierre KLEIN

Conf.

Application No. NEW NATIONAL PHASE

Group

Filed June 2, 2006

Examiner

DEVICE FOR THE EARTHQUAKE-RESISTANT MOUNTING OF A PARTITION

## INFORMATION DISCLOSURE STATEMENT (SUBMISSION CONCURRENT WITH THE FILING OF A NEW PATENT APPLICATION)

Assistant Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

June 2, 2006

Sir:

Pursuant to 37 C.F.R. §§ 1.97 and 1.98, and in fulfillment of the duty of disclosure under 37 C.F.R. § 1.56, applicant(s) hereby submit(s) an Information Disclosure Statement for consideration by the Examiner.

## I. LIST OF PATENTS, PUBLICATIONS OR OTHER INFORMATION

The patents, publications, or other information submitted for consideration by the Office are listed on PTO-1449, attached hereto.

## II. COPIES

Copies	of	the	U.S.	patents	or pu	ublications	are	not	submitte	d
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filed	afte.	r Jur	ne 30,	2003.						

- Submitted herewith is a legible copy of (i) each foreign patent; (ii) each publication or that portion which caused it to be listed; and (iii) all other information or that portion which caused it to be listed.
- This application is a National Phase of a PCT application. Some or all of the documents listed on the PTO-1449 are not enclosed because they were cited in the International Search Report and copies should have been forwarded from the International Search Authority pursuant to the trilateral agreement between the USPTO, EPO and JPO, or they are U.S. patents or U.S. published applications. If copies are needed, please contact the undersigned.

LU/361541

Docket No. 0598-1010 III. CONCISE EXPLANATION OF THE RELEVANCE AP20 Rec'd PCT/PTO 02 JUN 2006 (check at least one box) DOCUMENTS IN THE ENGLISH LANGUAGE a. The attached non U.S. patents, non U.S. patent application publications, foreign publications, or other information in the English language do not require a statement of relevancy. DOCUMENTS NOT IN THE ENGLISH LANGUAGE b. П A concise explanation of the relevance of all patents, publications, or other information listed that is not in the English language is as follows: FOREIGN SEARCH REPORT OR ACTION  $\boxtimes$ c. An English language version of the search report or action that indicates the degree of relevance found by the foreign office is attached, thereby satisfying the requirement explanation. See MPEP 609(A)(3). for concise а OTHER d. The following additional information is provided for the Examiner's consideration. **FEES** Disclosure Statement is being Information concurrently with the filing of a new patent application; therefore, no fee is required. If The Examiner has any questions concerning this IDS, he/she is requested to contact the undersigned. Respectfully submitted, YOUNG & THOMPSON Il Castel Benoit Castel, Reg. No. 35,041 745 South 23<sup>rd</sup> Street

Arlington, VA 22202 Telephone (703) 521-2297 Telefax (703) 685-0573 (703) 979-4709

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Enclosures:	$\boxtimes$	Form PTO-1449(s)
	$\boxtimes$	Documents
	$\boxtimes$	Foreign Search Report
		Other:

IAP20 Rec'd PCT/PTQ vi 2 JUN 2006 Sheet 1 of 1

INFORMATION DISCLOSURE CITATION			0598-1010		NEW NATIONAL PHASE			
	IN AN APPLICATION	Applicant: Jean-Pierre KLEIN						
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		U.S. PATE	NT DOCUMENTS					
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<sup>\*</sup> English language abstract provided for the Examiner's convenience